



P-Channel 150-V (D-S) MOSFET

PRODUCT SUMMARY

V_{DS} (V)	$r_{DS(on)}$ (Ω)	I_D (A) ^a	Q_g (Typ)
- 150	1.2 at $V_{GS} = - 10$ V	- 1.3	4.8 nC
	1.3 at $V_{GS} = - 6$ V	- 1.2	

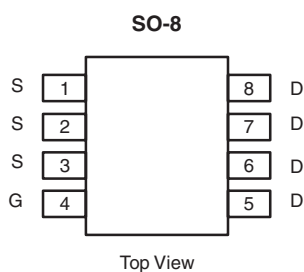
FEATURES

- TrenchFET® Power MOSFET
- 100 % UIS Tested

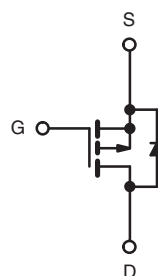
RoHS
COMPLIANT

APPLICATIONS

- Active Clamp Switch
- Isolated DC/DC Converters



Ordering Information: Si4409DY-T1-E3 (Lead (Pb)-free)



P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS $T_A = 25\text{ }^{\circ}\text{C}$, unless otherwise noted

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	- 150	V
Gate-Source Voltage	V_{GS}	± 20	
Continuous Drain Current ($T_J = 150\text{ }^{\circ}\text{C}$)	I_D	$T_C = 25\text{ }^{\circ}\text{C}$ - 1.3	A
		$T_C = 70\text{ }^{\circ}\text{C}$ - 1.0	
		$T_A = 25\text{ }^{\circ}\text{C}$ - 0.9 ^{b,c}	
		$T_A = 70\text{ }^{\circ}\text{C}$ - 0.7 ^{b,c}	
Pulsed Drain Current	I_{DM}	- 2	
Continuous Source-Drain Diode Current	I_S	$T_C = 25\text{ }^{\circ}\text{C}$ - 1.3	
		$T_A = 25\text{ }^{\circ}\text{C}$ - 0.9 ^{b,c}	
Avalanche Current	I_{AS}	4	
Single-Pulse Avalanche Energy	E_{AS}	0.8	mJ
Maximum Power Dissipation	P_D	$T_C = 25\text{ }^{\circ}\text{C}$ 4.6	W
		$T_C = 70\text{ }^{\circ}\text{C}$ 2.9	
		$T_A = 25\text{ }^{\circ}\text{C}$ 2.2 ^{b,c}	
		$T_A = 70\text{ }^{\circ}\text{C}$ 1.4 ^{b,c}	
Operating Junction and Storage Temperature Range	T_J, T_{stg}	- 55 to 150	$^{\circ}\text{C}$

THERMAL RESISTANCE RATINGS

Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{b, d}	$t \leq 5$ sec	R_{thJA}	47	55	$^{\circ}\text{C}/\text{W}$
Maximum Junction-to-Foot	Steady State	R_{thJF}	22	27	

Notes:

- $T_C = 25\text{ }^{\circ}\text{C}$.
- Surface Mounted on 1" x 1" FR4 board.
- $t = 5$ sec.
- Maximum under Steady State conditions is $95\text{ }^{\circ}\text{C}/\text{W}$.

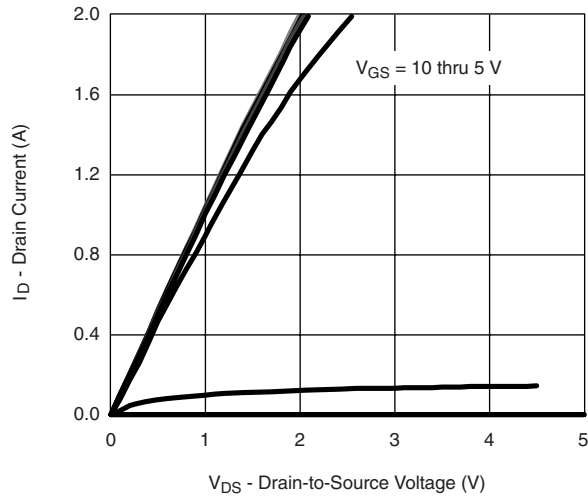
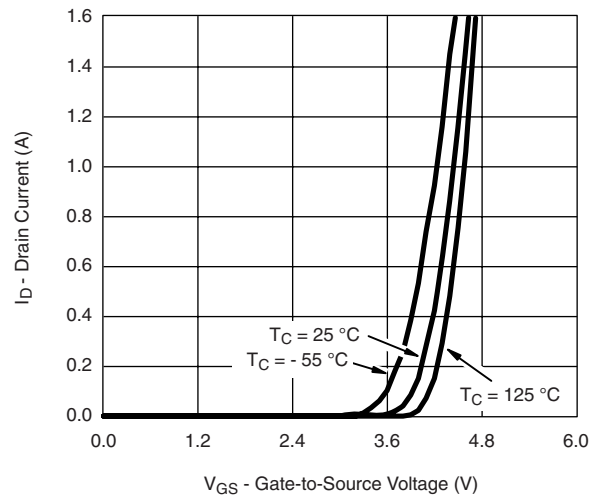
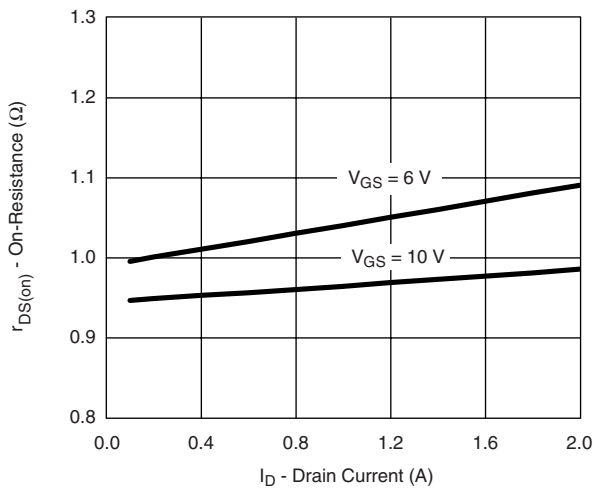
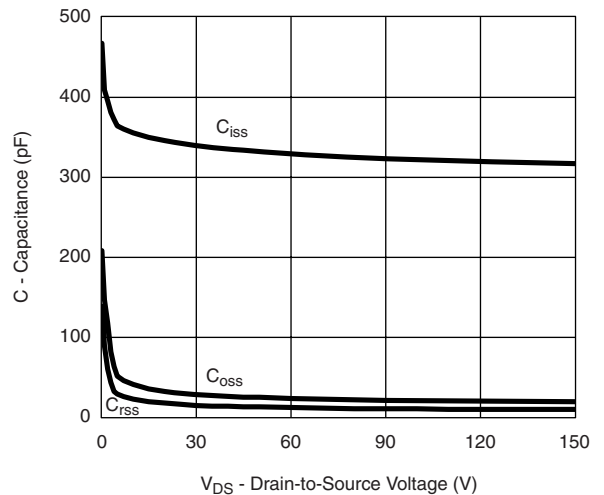
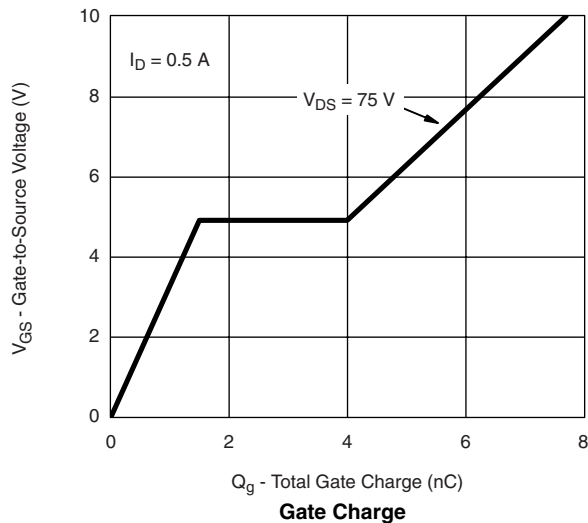
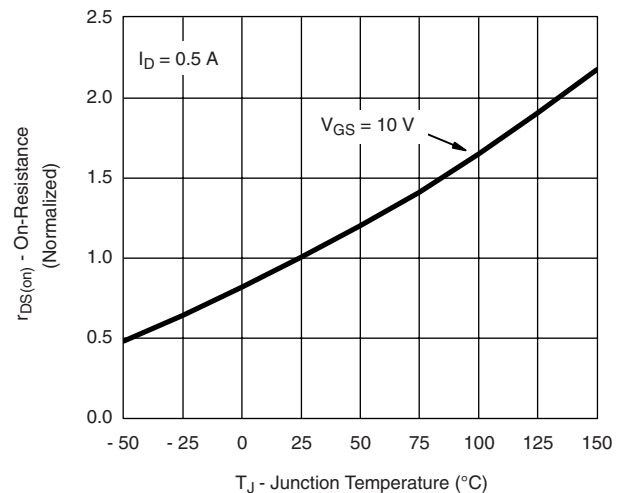
SPECIFICATIONS T _J = 25 °C, unless otherwise noted						
Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Static						
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA	- 150			V
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	I _D = - 250 μA		- 160		mV/°C
V _{GS(th)} Temperature Coefficient	ΔV _{GS(th)} /T _J			5.5		
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = - 250 μA	- 2		- 4	V
Gate-Source Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = ± 20 V			± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 150 V, V _{GS} = 0 V			- 1	μA
		V _{DS} = - 150 V, V _{GS} = 0 V, T _J = 55 °C			- 10	
On-State Drain Current ^a	I _{D(on)}	V _{DS} ≥ - 10 V, V _{GS} = - 10 V	- 2			A
Drain-Source On-State Resistance ^a	r _{DS(on)}	V _{GS} = - 10 V, I _D = - 0.5 A		0.95	1.2	Ω
		V _{GS} = - 6 V, I _D = - 0.5 A		1.0	1.3	
Forward Transconductance ^a	g _{fs}	V _{DS} = - 10 V, I _D = - 0.5 A		2.2		S
Dynamic ^b						
Input Capacitance	C _{iss}	V _{DS} = - 50 V, V _{GS} = 0 V, f = 1 MHz		332		pF
Output Capacitance	C _{oss}			25		
Reverse Transfer Capacitance	C _{rss}			13		
Total Gate Charge	Q _g	V _{DS} = - 75 V, V _{GS} = - 10 V, I _D = - 0.5 A		7.7	12	nC
		V _{DS} = - 75 V, V _{GS} = - 6 V, I _D = - 0.5 A		4.8	7.5	
Q _{gs}			1.5			
Q _{gd}			2.5			
Gate Resistance	R _g	f = 1 MHz		9		Ω
Turn-On Delay Time	t _{d(on)}	V _{DD} = - 75 V, R _L = 75 Ω I _D ≅ - 1 A, V _{GEN} = - 10 V, R _g = 6 Ω		7	14	ns
Rise Time	t _r			10	20	
Turn-Off DelayTime	t _{d(off)}			16	30	
Fall Time	t _f			9	18	
Turn-On Delay Time	t _{d(on)}	V _{DD} = - 75 V, R _L = 75 Ω I _D ≅ - 1 A, V _{GEN} = - 6 V, R _g = 1 Ω		7	14	
Rise Time	t _r			10	20	
Turn-Off DelayTime	t _{d(off)}			13	25	
Fall Time	t _f			10	20	
Drain-Source Body Diode Characteristics						
Continous Source-Drain Diode Current	I _S	T _C = 25 °C			- 1.3	A
Pulse Diode Forward Current	I _{SM}				- 2.0	
Body Diode Voltage	V _{SD}	I _S = - 1 A, V _{GS} = 0 V		- 0.7	- 1.2	V
Body Diode Reverse Recovery Time	t _{rr}	I _F = - 1.2 A, di/dt = 100 A/μs, T _J = 25 °C		43	70	ns
Body Diode Reverse Recovery Charge	Q _{rr}			95	150	nC
Reverse Recovery Fall Time	t _a			40		ns
Reverse Recovery Rise Time	t _b			3		

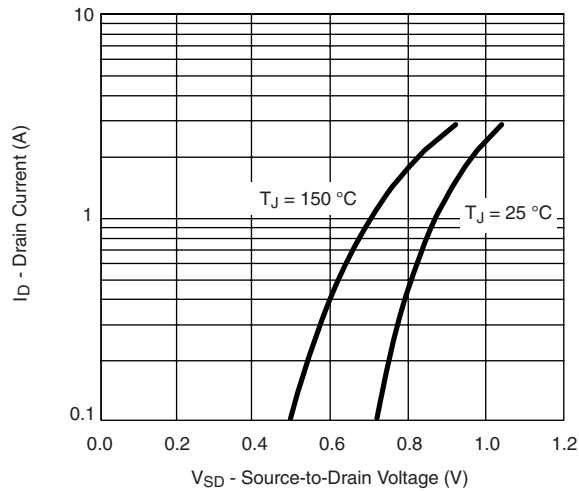
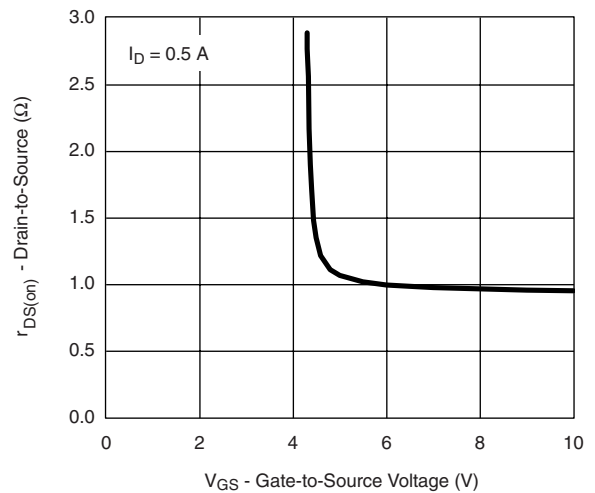
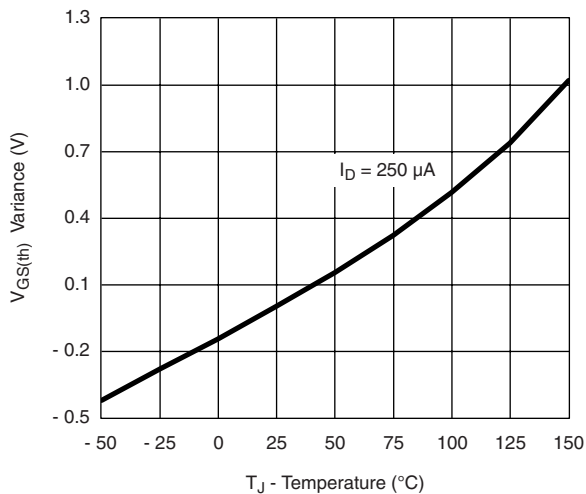
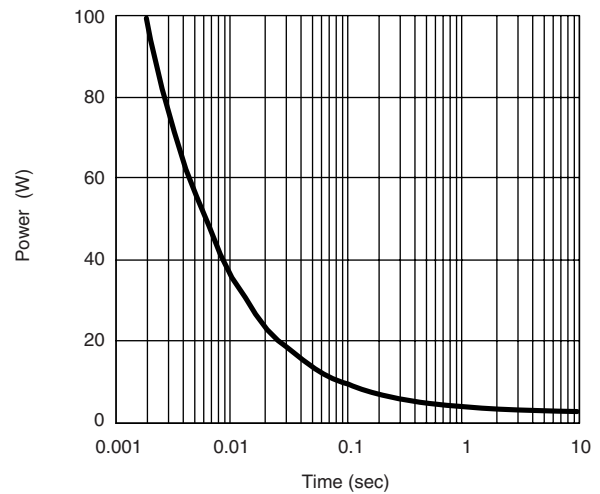
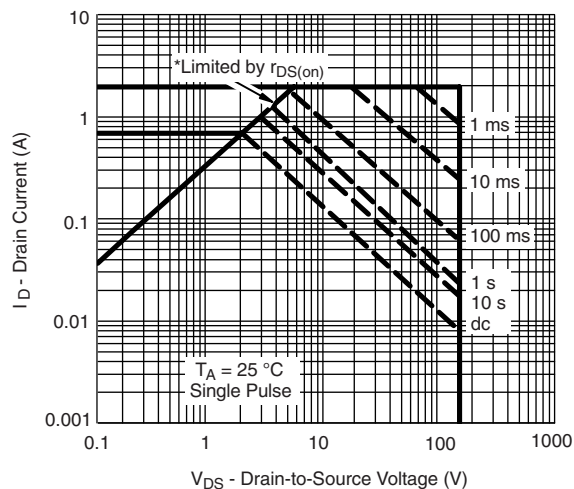
Notes:

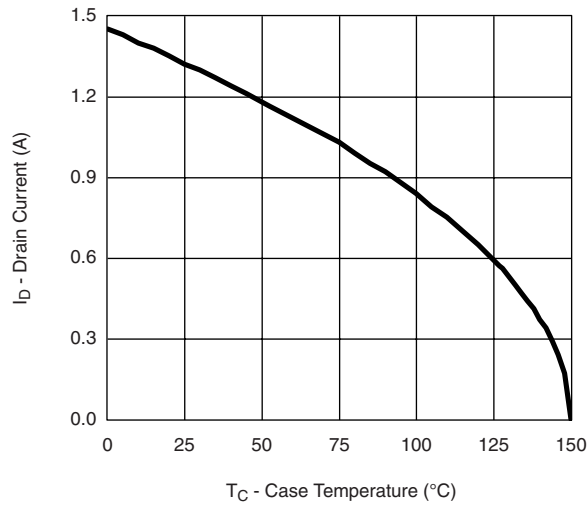
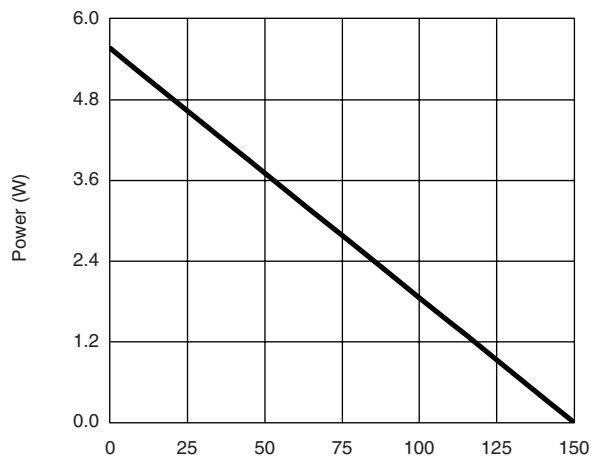
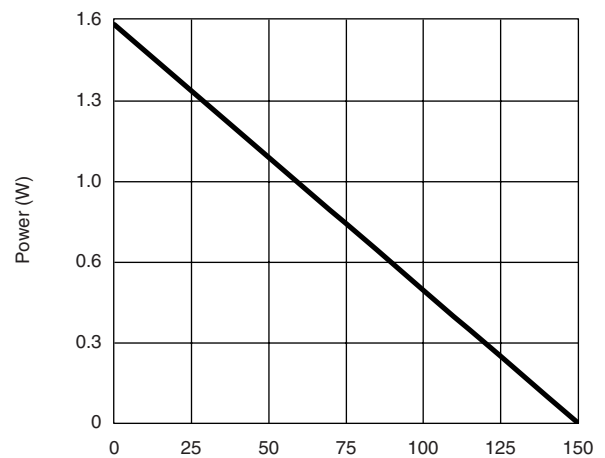
a. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.

b. Guaranteed by design, not subject to production testing.

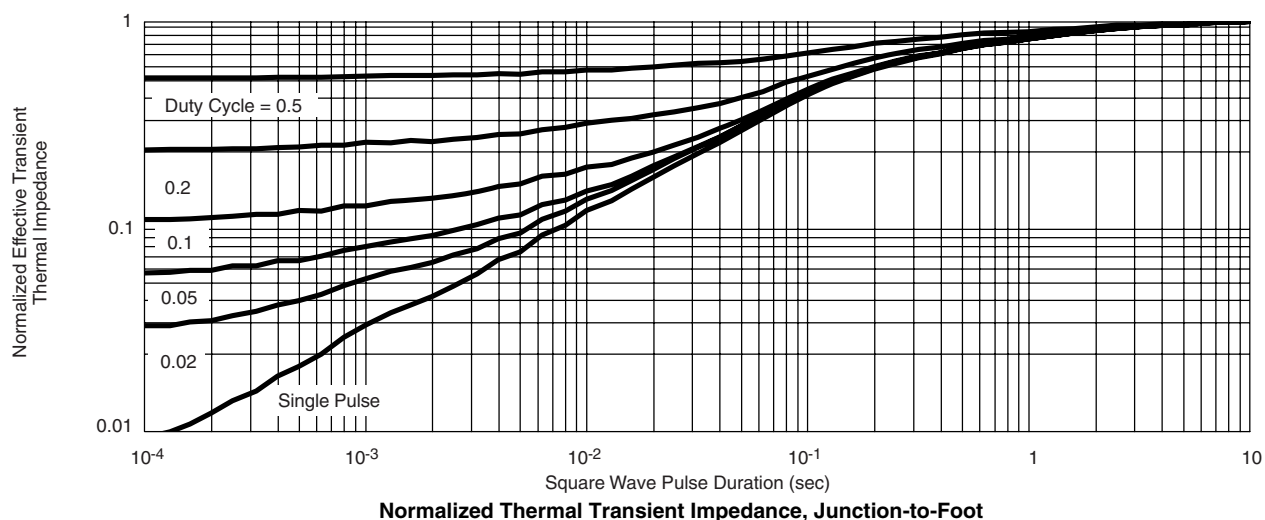
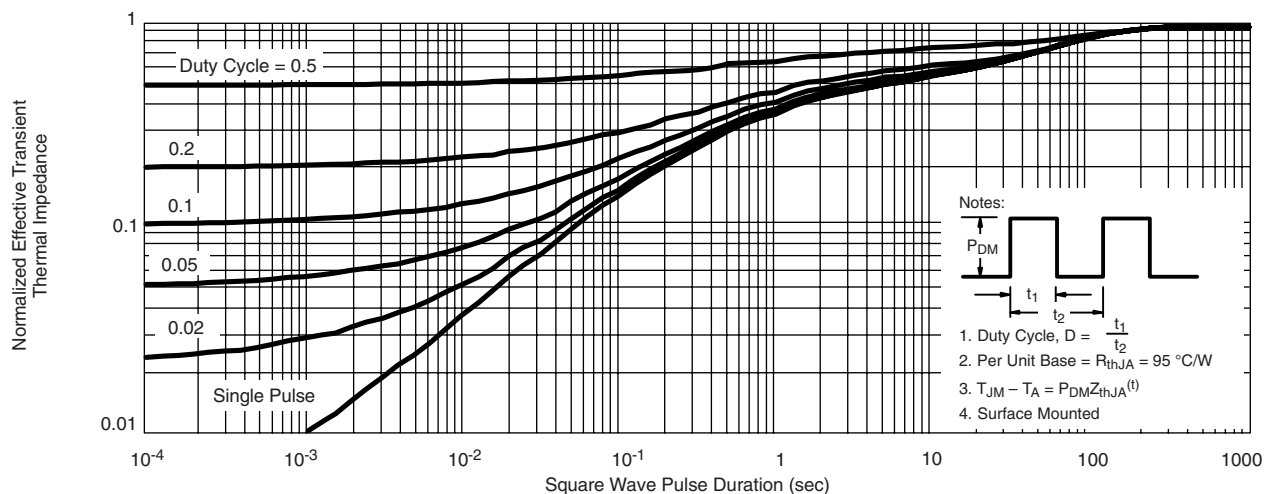
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted**Output Characteristics****Transfer Characteristics****On-Resistance vs. Drain Current and Gate Voltage****Capacitance****Gate Charge****On-Resistance vs. Junction Temperature**

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted**Source-Drain Diode Forward Voltage****On-Resistance vs. Gate-to-Source Temperature****Threshold Voltage****Single Pulse Power, Junction-to-Ambient*** $V_{GS} >$ minimum V_{GS} at which $r_{DS(on)}$ is specified**Safe Operating Area, Junction-to-Ambient**

**MOSFET TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted**Current Derating*****Power, Junction-to-Foot****Power Derating, Junction-to-Ambient**

*The power dissipation P_D is based on $T_{J(max)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

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